[Total No. of Questions - 9] [Total No. of Printed Pages - 3] (2064)

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B. Tech 4th Semester Examination

Electronic Measurement and Measuring Instruments (N.S.) EC-222

Time: 3 Hours Max. Marks: 100

The candidates shall limit their answers precisely within the answerbook (40 pages) issued to them and no supplementary/continuation sheet will be issued.

Note: Candidates are required to attempt five questions in all selecting one question from each of the sections A, B, C & D of question paper and all the subparts of the questions in Section E. Use of scientific calculator is permitted.

SECTION - A

- 1. (a) Explain the various types of systematic errors classified in measurement. Discuss the means adopted to minimize these errors. (10)
 - (b) Derive the equations for capacitance and dissipation factor of a low voltage Scheering Bridge. Draw the phasor diagram for conditions under balance. Discuss the advantages and disadvantages of the bridge. (10)
- (a) What are the different factors which affect the precision measurement of medium resistances with Wheatstone bridge? Explain how their effects are minimized/ eliminated? (10)
 - (b) Discuss the followings in brief:
 - (i) Meggar (ii) Static characteristics of instrument (10)

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SECTION - B

- 3. (a) Explain the effect of following on the performance of potential transformers:
 - (i) burden of secondary winding circuit (ii) power factor of secondary winding circuit (iii) frequency (12)
 - (b) Describe the term, 'total harmonic distortion'. Describe the function of a total harmonic distortion meter. (8)
- 4. (a) Describe the various characteristics of potential transformer. How will you improve the accuracy of potential transformer? (10)
 - (b) Describe the basic circuit of a spectrum analyser. Explain how the spectra of amplitude modulated signals, frequency modulated signals and phase modulated signals is displayed? (10)

SECTION - C

- 5. (a) Derive an expression for vertical deflection of an electron beam in a CRT. (10)
 - (b) Describe the different criteria for selection of transducer for a particular application. (10)
- 6. (a) Explain with diagrams, the bounded and unbounded types of strain gauges. (10)
 - (b) Describe the followings:
 - (i) Types of alphanumeric displays (ii) sampling oscilloscope (iii) Electronic multimeter (10)

SECTION - D

7. Explain the working of torque balancing telemetering system and PCM telemetering system in detail. (20)

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- 8. Discuss the followings:
 - (i) Data Acquisition System (ii) Computer Controlled test systems (20)

SECTION - E

- 9. (i) What is the difference between precision and accuracy?
 - (ii) What are the different calibration methodologies?
 - (iii) What is standard? What are the different types of standards?
 - (iv) What are the advantages and disadvantages of Owen's bridge?
 - (v) What are the different types of distortions in amplifiers?
 - (vi) What are the sources of error in current transformer?
 - (vii) What are the advantages and disadvantages of LCD display?
 - (viii) What is the difference between analog and digital transducer?
 - (ix) What are the advantages and disadvantages of current telemetry system?
 - (x) What is difference between XY recorder and magnetic recorder? (2×10=20)